Coating Thickness Measurement Instruments FMP10, FMP20, FMP30 and FMP40.

The Flexible Solution for Your Measurement Applications



State-of-the-Art Coating Thickness Measurement

The Fischer proven portable instruments with exchangeable probes allows for non-destructive and highly precise measurements of coatings. Whether for quality control in a manufacturing process or incoming inspection of random samples or complete batches, these user-friendly and flexible instruments will meet your requirements.

Select the appropriate instrument from the FMP family and combine it with one of our high-precision measurement probes.

Quality monitoring on engine pistons immediately after the manufacturing process using the FTA3.3H probe

Special features

- Fast and non-destructive measurement on steel or iron (F) and non-ferrous metals (NF)
- Automatic probe and base material recognition
- Large colour display
- Supports measurements according to IMO PSPC, SSPC-PA2, QUALANOD and QUALICOAT
- USB interface or COM interface as option
- Over 70 various high-precision probes for even the most sophisticated measurement applications



Measurements using the internal probe FAI 3.3-150



Paint coating thickness measurement using the dual probe FD13H

FMP10, FMP20, FMP30 and FMP40 Instrument Overview

DELTASCOPE®	DUALSCOPE®	ISOSCOPE®	Storable meas. applications	Statistics, evaluation	Measurement strategies
11.7	92.3	39.7	1	Display of the most significant statistical values (number of measurements, mean value, standard deviation, min, max, range)	Single reading acquisition Free-running display
DELTASCOPE® FMP10	DUALSCOPE® FMP20	ISOSCOPE® FMP10			
DELTASCOPE® FMP30	DUALSCOPE® FMP40	ISOSCOPE® FMP30	up to 100	Display of the most significant statistical values (number of measurements, mean value, standard deviation, min, max, range) and specific values Tolerance monitoring Graphical evaluation	Single reading acquisition Free-running display Area measurement Multiple measurements Automatic measurement Matrix mode IMO PSPC SSPC-PA2 QUALICOAT
Magnetic induction method (DIN EN ISO 2178,	magnetic induction method	Eddy current method (DIN EN ISO 2360,			
	DELTASCOPE® FMP10 DELTASCOPE® FMP30 Magnetic induction method	DELTASCOPE® FMP10 DUALSCOPE® FMP20 DELTASCOPE® FMP30 DUALSCOPE® FMP40 Magnetic induction method (DIN EN ISO 2178, magnetic induction method magnetic induction method magnetic induction method	DELTASCOPE® FMP10 DUALSCOPE® FMP20 ISOSCOPE® FMP10 DUALSCOPE® FMP40 ISOSCOPE® FMP30 Magnetic induction method (DIN EN ISO 2178, magnetic induction method (DIN EN ISO 2360, magnetic induction method (DIN EN ISO 2360,	DELTASCOPE® FMP10 DUALSCOPE® FMP20 ISOSCOPE® FMP10 DUALSCOPE® FMP20 ISOSCOPE® FMP10 Up to 100 DUALSCOPE® FMP40 ISOSCOPE® FMP30 DUALSCOPE® FMP40 Eddy current method (DIN EN ISO 2178, page 1278, page 1278) Eddy current method (DIN EN ISO 2360, page 1380) Eddy current method (DIN EN ISO 2360, page 1380)	DELTASCOPE® FMP10 DUALSCOPE® FMP20 DUALSCOPE® FMP20 DUALSCOPE® FMP20 DUALSCOPE® FMP40 DUALSCOPE® FMP30 DUALSCOPE® FMP40 DUALSCOPE® FMP30 DUALSCOPE® FMP40 Eddy current method (DIN EN ISO 2360), DELTASCOPE® FMP30 DUALSCOPE® FMP40 Eddy current method (DIN EN ISO 2360), DUALSCOPE® FMP30 DUALSCOPE® FMP40 Eddy current method (DIN EN ISO 2360),

DELTASCOPE® FMP10 and FMP30

For the measurement on ferrous base materials (F), e.g. paint, lacquer, powder coating, chrome, copper, zinc, as well as enamel or plastic coatings on steel and iron.

ISOSCOPE® FMP10 and FMP30

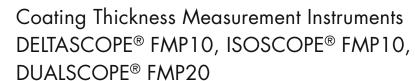
For the measurement of paint, powder coating, lacquer or plastic coatings on non-ferromagnetic metal base materials (NF) or anodic coatings or aluminum and electrically conducting coatings on non-conducting carrier materials.

DUALSCOPE® FMP20 and FMP40

Due to automatic base material recognition and the integration of both measurement methods, these universal instruments are capable of measuring coatings on steel and iron (F) and on non-ferromagnetic metals (NF). Duplex coatings (lacquer/zinc) on steel can be measured simultaneously with the values of the lacquer and zinc coatings displayed individually.



DUALSCOPE® FMP40 using the duplex probe FDX13H







DELTASCOPE® FMP10 using the probe FGAB1.3

The portable FMP10 and FMP20 represent precise measurement technology and are ideal for samples and control measurement. These user-friendly and sturdy instruments can be adapted to all requirements of coating thickness measurement using exchangeable measuring probes. The most significant statistical values are displayed and can be stored together with the calibration in the instrument, ensuring quick and reliable operation.

Features of the FMP10 and FMP20

Instrument features

- For magnetic induction and eddy current probes
- Automatic base material and probe recognition
- Easy-to-use with intuitive menu
- Large contrast-rich colour display
- Memory for up to 1,000 readings
- USB interface
- Instant measurement upon probe placement
- Audible signal with measurement acquisition
- Easy adaptation to the shape of the specimen through a zero-point correction (normalization)
- Easy to perform corrective calibration (verification of accuracy)
- Sliding cover to protect keys against unintentional operation
- Various language settings
- \bullet Units of measurement can be switched between μm and mils

Measurement strategies and evaluation

- Single reading acquisition
- Measurements with the "free-running display" mode for continuous scanning of surfaces
- Statistical display of significant values such as mean value, standard deviation, min, max, range



DUALSCOPE® FMP20 using the probe FTD3.3



ISOSCOPE® FMP10 using the probe FTA3.3-Cu



Coating Thickness Measurement Instruments DELTASCOPE® FMP30, ISOSCOPE® FMP30, DUALSCOPE® FMP40

Additional features of the FMP30 and FMP40

Instrument features

- External key-triggered measurement acquisition,
 e.g. in hollow cylinders with small diameters
- Audible and visual warning when tolerance limits are exceeded
- Option USB or COM interface

Measurement application memory

- Application memory for up to 100 measuring applications incl. calibration (adjustment settings)
- Memory for up to 20,000 readings
- Allocation of readings into up to 4,000 blocks
- Date and time stamp for blocks
- Application linking mode: Common normalization/ calibration of measuring applications
- Validation of the corrective calibration by test measurements on standards

Measurement strategies and evaluation

- Stored specifications for measurements according to IMO PSPC, SSPC-PA2, QUALANOD and QUALICOAT
- Capability to enable matrix measurement mode for correlated multi-point measurements
- Averaging of measurement data: Only the mean value of several readings will be stored
- Measurement acquisition through area measurement: Single readings are captured until probe lift-off and averaged
- Outlier rejection settings for automatic elimination of erroneous measurements
- Free-running display with additional presentation of the reading as an analog bar between the tolerance limits
- Statistics display of the most significant values in the block and final results. Output of variance-analytical values
- Graphical measurement display as a histogram
- Capability of entering process tolerance limits and computation of the associated process capability indices c_p and c_{pk}



ISOSCOPE® FMP30 using probe FTA3.3H



DELTASCOPE® FMP30 using dual-tip probe V7FKB4



DUALSCOPE® FMP40 using probe FD13H

The FMP30 and FMP40 instruments feature additional more memory for numerous customer-specific measuring applications as well as extensive graphical and statistical evaluations. Tolerance limits can be entered into the calibratable measuring applications and the production process can be analyzed statistically.



DUALSCOPE® FMP40 using the probe FGAB1.3 and support stand V12 BASE – measuring parts with position accuracy

Versatile Probes Program and Ordering Information

Probe program

The extensive selection of FISCHER probes is as versatile as the measurement applications of our customers. A probe needs specific properties for each field of application for achieving best results with a high accuracy. Over 70 probes can be connected to the instrument family FMP10 to FMP40. Thus, you can solve even the most sophisticated measurement tasks.

Probe selection based on several criteria

- Material combination of coating and base material
- Thickness of coating and base material
- Dimension of the measurement area
- Shape of the specimen
- Surface condition of the measurement area

Call us

We are happy to consult you on the matter of choosing



Ordering information	Order no.
DELTASCOPE® FMP10	605-021
ISOSCOPE® FMP10	605-027
DUALSCOPE® FMP20	605-023
DELTASCOPE® FMP30	605-022
ISOSCOPE® FMP30	605-028
DUALSCOPE® FMP40	605-024

Standard content of instrument shipment

- Instrument
- Short form operator's manual, print version
- Carrying strap FMP
- USB interface cable FMP/PC
- Battery set FMP (Alkaline)
- Carrying case FMP only for FMP30 and FMP40 instruments

Optional accessories	Order no.
Carrying case FMP	604-148
Adapter E-probe/F-socket	604-214
AC adapter FMP30 and FMP40	604-290
Rechargeable battery set FMP (NiMH)	604-295
Charger AA/Mignon	604-335
Measurement stand V12 BASE	604-420
Measurement stand V12 MOT	604-374
(motor-driven)	
COM Module FMP30/FMP40,	604-500
RS232 interface	
Interface connection set for COM Module	602-341
Protective cover for instrument	604-149

Service worldwide

FISCHER has established a tightly-linked global network of service partners with highly qualified staff. Offering fast help, repairing and the availability of leasing and rental units, FISCHER supports you in every respect concerning your instruments and their use.

Calibration and certification

On your request Fischer issues a Quality Inspection Certificate for your probe and instrument according to DIN 55350-18. A broad assortment of calibration foils is available from FISCHER. On your request FISCHER issues a Factory Certificate for your calibration foil.



Application laboratories

More and more, demanding applications require highly qualified application advice. FISCHER addresses this need with its application laboratories located around the world (Germany, Switzerland, China, USA, India, Japan and Singapore).



Measuring on a customer's specimen in a FISCHER application laboratory

User on-site training

With our training program we make your employees fit on-site for your measuring task. Our trainer takes account of your individual requirements and wishes.



User training for the DUALSCOPE $^{\!\otimes}$ FMP100 on-site at the customer's

Seminars

Because we want you to receive maximum benefit from our products, FISCHER's experts are happy to share their application know-how. The seminars not only teach metrological basics but also hand-on experience in small groups to put the theory into practice.



A FISCHER seminar teaches metrological basics and practical knowledge in small groups

Global Sales Global Application Global Service



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